

**Search Notes**

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Applicant(s)/Patent under  
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KACHI ET AL.

Art Unit

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**SEARCHED**

Class	Subclass	Date	Examiner
257	13 79-84 97-99	4/12/2006	TT

**INTERFERENCE SEARCHED**

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**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
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